Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	•
10/650,152	LEE ET AL.	
Examiner	Art Unit	
David B. Lugo	2611	

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Class	Subclass	Date	Examiner
375	259, 260 267, 295 299	1/7/2007	DL

INT	INTERFERENCE SEARCHED		
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	DATE	EXMR
Inventor search East search	1/7/2007	DL